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	AB	5,13	14,085	07/28/92	GILGEN E	ET AL.									
	AC	5,17	5,774	12/29/92	TRUAX E	T AL.									
	AD	5,27	72,367	12/21/93	DENNISO	N ET AL.									
	Æ	5,38	15,551	11/15/94	SNODGRA	ASS ET AL									
	AF	5,48	19,546	02/05/95	AHMAD E	IT AL.									
,	AG	5,50	00,850	03/19/98	SNODGR/	ASS ET AL.									
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. ,	A	5,32	23,150	06/21/94	TUTTLE										
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	AR		VITTOZ, ERIC,	, ET AL, <u>'CMOS</u>	3 Analog Inte	egrated Circuits Base	d on Weak Invers	lon Op	eration	, IEEE	Journ	8 1 04			
BZ			Solid State Ci	droulis, Vol. SC-1	12, No. 3, J	June 1977									
BŻ	AS		Mitsubishi Mata	ors Corporation,	, "Edipse", V	Veb Page, 1993									
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BZ	AT		TUTTLE, JOHN	R., Digital RF	/ID Enhance	s GPS*, Proceedings	of the Second An	mual V	Vireless	э Зутро	osium,	pp.408-411,			
			February 15-	-18, 1994, Senta	Clare, CA										
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	AB	5,42	5,420,757 05/30/95 EBERHAR			DT ET AL.							
	AC	4,57	2,976	02/25/88	FOCKENS								
	AD	4,72	4,427	02/09/88	CARROLL								
	AE	4,85	4,328	08/08/89	POLLACK								
	AF	5,30	0,875	04/05/94	TUTTLE								:
	AG	4,86	2,160	08/28/89	EKCHIAN	ET AL							
	AH.	5,47	5,471,212 11/28/95			ET AL.							
	AJ	4.87	4,870,419 09/26/89			ET AL.			·			,	
V	. ~	4,88	18,591	12/19/89	LANDT ET AL								
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	AR		*Micron Mornin	g Report, The	Idaho States	man, July 16, 1993.							
BZ						·							
	AS		TUTTLE, JOHN	R., 'A Low-Por	wer Spread :	Spectrum CMOS RFI	of Radio Identific	ation	Applic	atlons		rence	
BZ		••••••	Proceedings	from RF Expo V	Vest, pp. 216	6-222, March 22-24,	1994, San Jose, C	A.					
	TA		FINK ET AL.	Electronics Engir	neer's Hando	ock · 3 st Ed., Distrib	uled Circuits, §100,	p. 8	104, €) 1989.			
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		AB	5,14	14,314	09.	9/01/92	MALMBER	G ET AL.							
		AC	5,16	4,985 ·	11	/17/92	NYSEN ET	T AL.							
		AD	5,28	7,112	02	2/15/94	SCHUERM								
		AE	4,85	37,89 3	08	3/1 5/8 9	CARROLL		,						
		AF	6,13	10,602	10.	2/10/00	OTOOLE	ET AL.							
		AG	5,97	0,398	10	V19/99	TUTTLE '								
		AH	5.64	9,296	07	/15/97	MacLEULA	N ET AL.			1				-
		AJ	5,62	1,412	04	V15/97	SHARPE E	ET AL							
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		AB 4,822,990 04/18/89			TAMADA	ET AL.										
		AC	5,479,172 12/28/95		SMITH ET	AL.										
		AĐ	5,52	5,521,600 05/28/98		MEEWAN	MEEWAN							•		
		AE	5,525,993 06/11/96		POBANZ (ET AL.										
		AF	5,66	\$8,560	OS	1/16/97	EVANS ET	T AL.								
		AG	3 4,826,220 04/25/89		EDWARD	· · · · · · · · · · · · · · · · · · ·						-				
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		Æ	5.49	14,495	02/27/98	TUTTLE									
		AF	5,48	10,834	01/02/98	LAKE ET	AL.								
		AG	4,21	5,341	07/29/80	COLE									
		АН	3,15	5,954	11/03/64	LARRICK	ET AL.								
		A	5,26	0,643	01/18/94	ISHII			:	·					
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